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FDP120N10 N-Channel PowerTrench[®] MOSFET 100 V, 74 A, 12 mΩ

Features

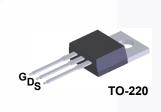
- $R_{DS(on)}$ = 9.7 m Ω (Typ.) @ V_{GS} = 10 V, I_D = 74 A
- · Fast Switching Speed
- Low Gate Charge
- High Performance Trench Technology for Extremely Low $R_{\text{DS}(\text{on})}$
- High Power and Current Handling Capability
- RoHS Compliant

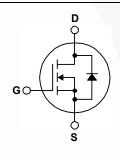
Description

This N-Channel MOSFET is produced using Fairchild Semiconductor's advanced PowerTrench[®] process that has been tailored to minimize the on-state resistance while maintaining superior switching performance.

Applications

- Synchronous Rectification for ATX / Server / Telecom PSU
- Battery Protection Circuit
- Motor Drives and Uninterruptible Power Supplies
- Micor Solar Inverter





MOSFET Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol		Parameter		FDP120N10	Unit	
V _{DSS}	Drain to Source Voltage			100	V	
V _{GSS}	Gate to Source Voltage			±20	V	
ID	Drain Current	- Continuous (T _C = 25 ^o C)		74	•	
	Drain Current	- Continuous (T _C = 100 ^o C)		52	— A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	296	А	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	198	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		(Note 3)	6.0	V/ns	
P _D	Dower Dissinction	(T _C = 25°C)		170	W	
	Power Dissipation	- Derate Above 25°C		1.14	W/ºC	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +175	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		nds	300	°C	

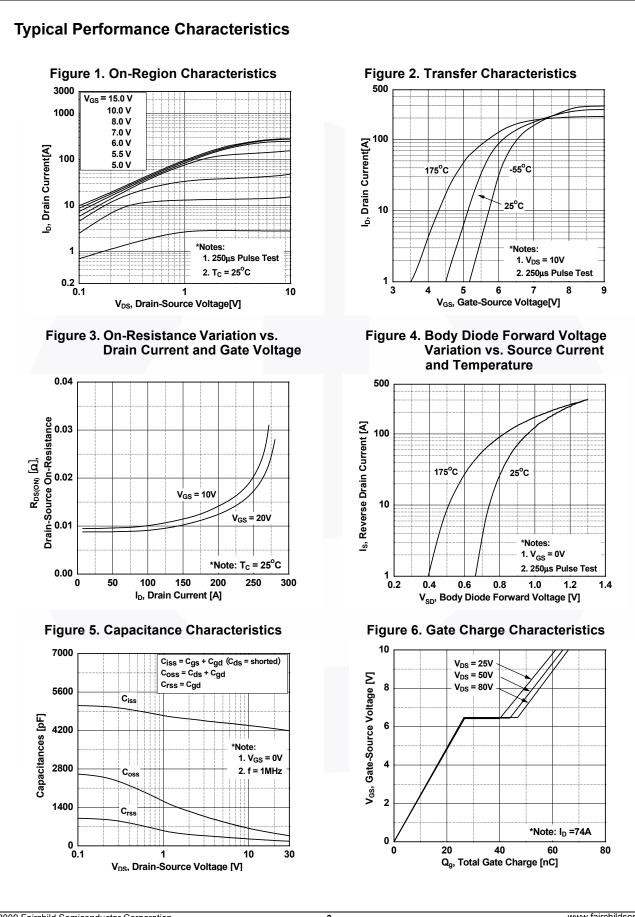
Thermal Characteristics

Symbol	Symbol Parameter		Unit
R _{0JC} Thermal Resistance, Junction to Case, Max.		0.88	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient, Max.	62.5	0/00

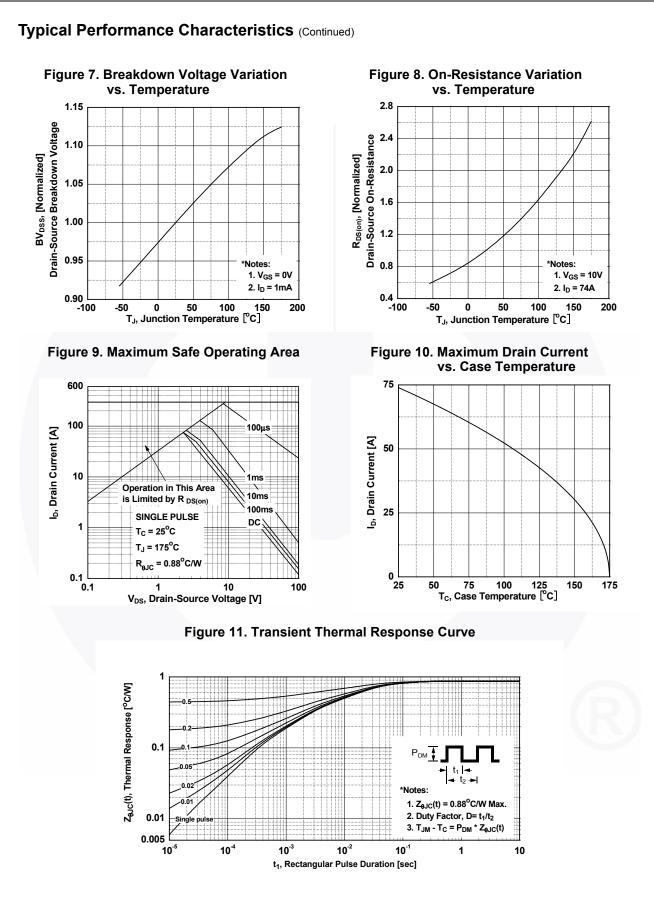
November 2013

i ait itaii	nber	Top Mark	Package	Packing Me	thod	Reel Size	Тар	e Width	Qua	ntity
FDP120			TO-220	Tube		N/A		N/A	50 units	
Electrica	l Chara	acteristics T _c = 25	^o C unless c	otherwise noted.	I					
Symbol		Parameter		Test C	onditio	ns	Min.	Тур.	Max.	Unit
Off Charac	teristics	5								
BV _{DSS}	Drain to	Source Breakdown Volta	age	I _D = 250 μA, V _{GS}	s = 0 V,	T _C = 25°C	100	-	-	V
ΔBV _{DSS} /ΔTJ	Breakdown Voltage Temperature			$I_D = 250 \ \mu\text{A}$, Referenced to 25°C			-	0.1	-	V/ºC
/ <u>4</u> 1j				V _{DS} = 100 V, V _{GS} = 0 V		-	-	1	<u> </u>	
DSS	Zero Ga	te Voltage Drain Current		$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, T_{C} = 150^{\circ}\text{C}$		-	-	500	μA	
I _{GSS}	Gate to Body Leakage Current			$V_{GS} = \pm 20 \text{ V}, \text{ V}_{D}$			-	-	±100	nA
On Charac	teristics	5								
V _{GS(th)}	Gate Th	reshold Voltage		$V_{GS} = V_{DS}, I_{D} =$	250 μA		2.5	-	4.5	V
R _{DS(on)}		rain to Source On Resista	ance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} =$			-	9.7	12	mΩ
9 _{FS}	Forward	Transconductance		$V_{DS} = 10 \text{ V}, \text{ I}_{D} = 74 \text{ A}$			-	105	-	S
Dynamic C	baracte	ristics								
C _{iss}	-	apacitance					-	4215	5605	pF
C _{oss}		Capacitance		V _{DS} = 25 V, V _{GS} = 0 V, f = 1 MHz		-	405	540	pF	
C _{rss}	-	Transfer Capacitance				-	170	255	pF	
Q _{g(tot)}		te Charge at 10V		V - 90 V I -	74 0		-	66	86	nC
Q _{gs}		Source Gate Charge		V _{DS} = 80 V I _D = 74 A, V _{GS} = 10 V		-	26	-	nC	
Q _{gd}		te to Drain "Miller" Charge		(Note 4)		-	20	-	nC	
Switching	Charact	eristics								
t _{d(on)}	-	Delay Time					-	27	64	ns
t _r		Rise Time		V_{DD} = 50 V, I _D = 74 A, V _{GS} = 10 V, R _G = 4.7 Ω		-	105	220	ns	
t _{d(off)}		Delay Time				-	39	88	ns	
t _f		Fall Time				(Note 4)	-	15	40	ns
		le Characteristics								
I _S	Maximum Continuous Drain to Source Diode Forward Current					-	-	74	A	
I _{SM}		n Pulsed Drain to Source				-	-	296	A	
V _{SD}	-	Source Diode Forward Vo		V _{GS} = 0 V, I _{SD} = 74 A		-	-	1.3	V	
t _{rr}		Recovery Time		V _{GS} = 0 V, I _{SD} = 74 A,		-	44	-	ns	
Q _{rr}	Reverse Recovery Charge			$dI_{F}/dt = 100 A/\mu s$		-	67	-	nC	

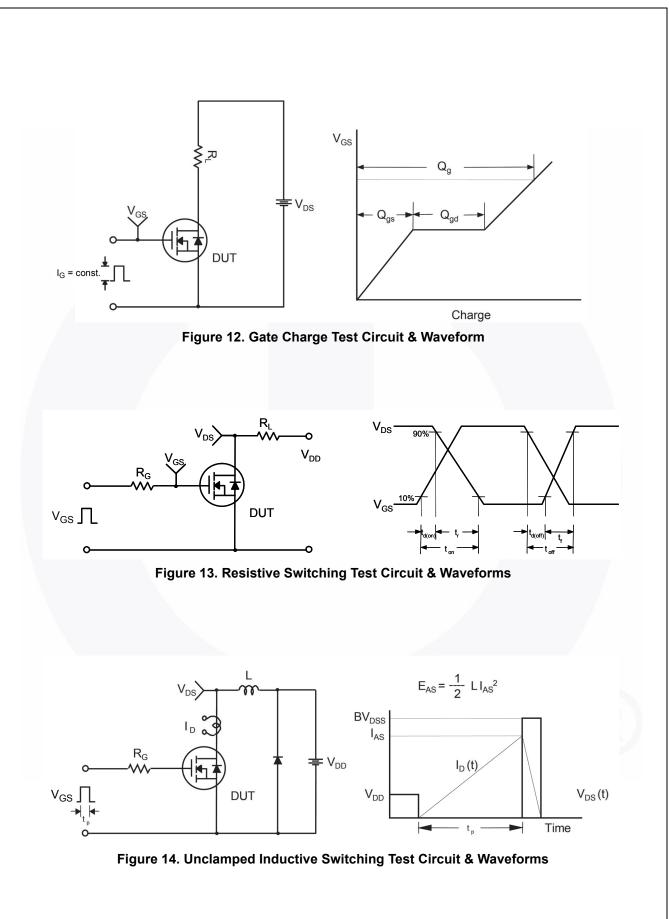
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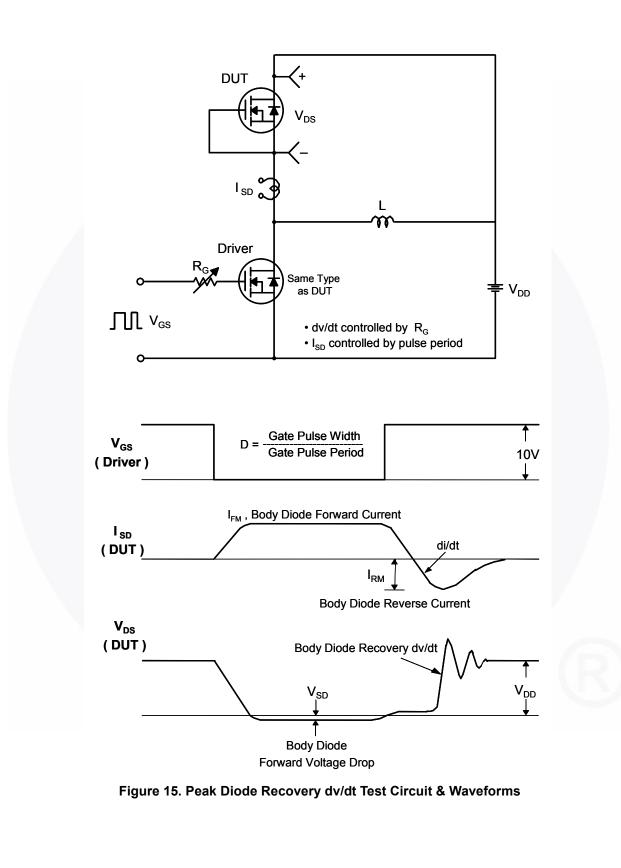


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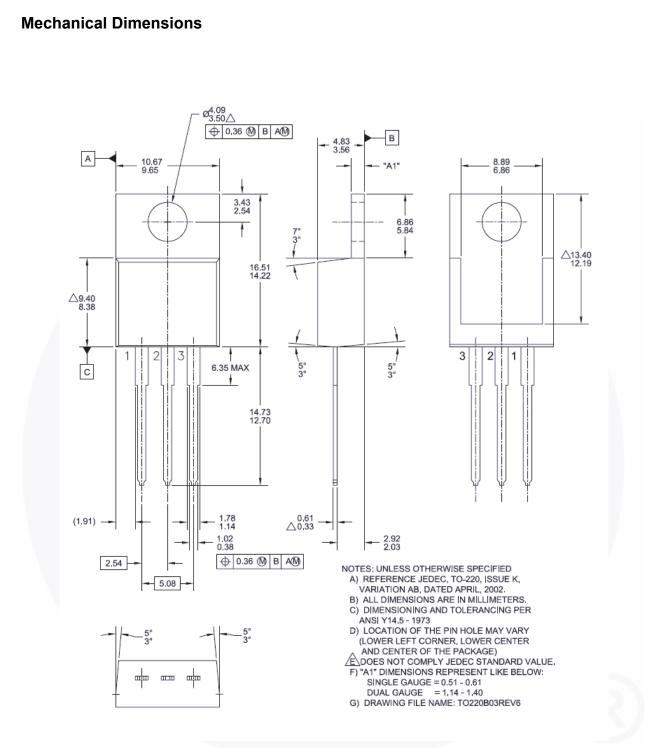


Figure 16. TO-220, Molded, 3-Lead, Jedec Variation AB

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